## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | YANAGISAWA ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,117,778	09-2000	Jones et al.	438/692
	В	US-5,997,653	12-1999	Yamasaka, Miyako	134/2
	O	US-5,953,578	09-1999	Lee, William Wei-Yen	438/9
	D	US-5,358,806	10-1994	Haraichi et al.	430/5
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2001-144072 A	05-2001	Japan	Yanagisawa et al	H01L 21/3065
	0					
	Р					
	Q					
	R					
	s					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.